

## **Search Notes**



**Application/Control No.**

09/727,364

Examiner

Hwei-Siu C. Payer

**Applicant(s)/Patent under  
Reexamination**

NICHOLS ET AL.

## **Art Unit**

3724

**SEARCHED**

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner